IRFP4332PBF Datasheet

https://www.DiGi-Electronics.com

DiGi Electronics Part Number	IRFP4332PBF-DG
Manufacturer	Infineon Technologies
Manufacturer Product Number	IRFP4332PBF
Description	MOSFET N-CH 250V 57A TO247AC
Detailed Description	N-Channel 250 V 57A (Tc) 360W (Tc) Through Hole TO-247AC

Purchase and inquiry

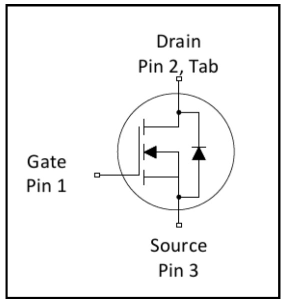
Manufacturer Product Number:	Manufacturer:
IRFP4332PBF	Infineon Technologies
Series:	Product Status:
HEXFET®	Active
FET Type:	Technology:
N-Channel	MOSFET (Metal Oxide)
Drain to Source Voltage (Vdss):	Current - Continuous Drain (Id) @ 25°C:
250 V	57A (Tc)
Drive Voltage (Max Rds On, Min Rds On):	Rds On (Max) @ Id, Vgs:
10V	33mOhm @ 35A, 10V
Vgs(th) (Max) @ Id:	Gate Charge (Qg) (Max) @ Vgs:
5V @ 250μA	150 nC @ 10 V
Vgs (Max):	Input Capacitance (Ciss) (Max) @ Vds:
±30V	5860 pF @ 25 V
FET Feature:	Power Dissipation (Max):
-	360W (Tc)
Operating Temperature:	Mounting Type:
-40°C ~ 175°C (TJ)	Through Hole
Supplier Device Package:	Package / Case:
TO-247AC	TO-247-3
Base Product Number:	
IRFP4332	

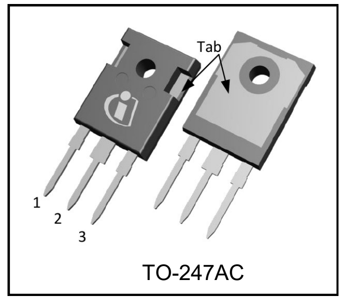
Environmental & Export classification

RoHS Status:	Moisture Sensitivity Level (MSL):
ROHS3 Compliant	1 (Unlimited)
REACH Status:	ECCN:
REACH Unaffected	EAR99
HTSUS:	
8541.29.0095	

IRFP4332PbF

V_{DSS} min	250V
$V_{DS\ (Avalanche)}$ typ.	300V
$R_{DS(on)}$ typ.	29mΩ
I_D	57A





Features

- Advanced Process Technology
- Key Parameters Optimized for PDP Sustain, Energy Recovery and Pass Switch Applications
- Low E_{PULSE} Rating to Reduce Power Dissipation in PDP Sustain, Energy Recovery and Pass Switch Applications
- Low Q_G for Fast Response
- High Repetitive Peak Current Capability for Reliable Operation
- Short Fall & Rise Times for Fast Switching
- 175°C Operating Junction Temperature for Improved Ruggedness
- Repetitive Avalanche Capability for Robustness and Reliability

Description

This HEXFET® Power MOSFET is specifically designed for Sustain; Energy Recovery & Pass switch applications in Plasma Display Panels. This MOSFET utilizes the latest processing techniques to achieve low on-resistance per silicon area and low E_{PULSE} rating. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for PDP driving applications

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRFP4332PbF	TO-247AC	Tube	25	IRFP4332PbF

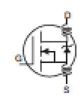
Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
V_{GS}	Gate-to-Source Voltage	± 30	V
I_D @ T_C = 25°C	Continuous Drain Current, V_{GS} @ 10V	57	A
I_D @ T_C = 100°C	Continuous Drain Current, V_{GS} @ 10V	40	
I_{DM}	Pulsed Drain Current ①	230	
I_{RP} @ T_C = 100°C	Repetitive Peak Current⑤⑥	120	
P_D @T_C = 25°C	Power Dissipation	360	W
P_D @T_C = 100°C	Power Dissipation	180	
	Linear Derating Factor	2.4	W/°C
T_J T_{STG}	Operating Junction and Storage Temperature Range	-40 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10lbf·in (1.1N·m)	

Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ④	——	0.42	°C/W
$R_{\theta CS}$	Case-to-Sink, Flat Greased Surface	0.24	——	
$R_{\theta JA}$	Junction-to-Ambient	——	40	

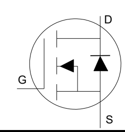
Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	250	——	——	V	V_{GS} = 0V, I_D = 250μA
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	——	170	——	mV/°C	Reference to 25°C, I_D = 1mA①
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	——	29	33	mΩ	V_{GS} = 10V, I_D = 35A ③
$V_{GS(th)}$	Gate Threshold Voltage	3.0	——	5.0	V	V_{DS} = V_{GS}, I_D = 250μA
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Coefficient	——	-14	——	mV/°C	
I_{DSS}	Drain-to-Source Leakage Current	——	——	20	μA	V_{DS} = 250V, V_{GS} = 0V
		——	——	200		V_{DS} = 250V, V_{GS} = 0V, T_J = 125°C
I_{GSS}	Gate-to-Source Forward Leakage	——	——	100	nA	V_{GS} = 20V
	Gate-to-Source Reverse Leakage	——	——	-100		V_{GS} = -20V
gfs	Forward Transconductance	100	——	——	S	V_{DS} = 25V, I_D = 35A
Q_g	Total Gate Charge	——	99	150	nC	V_{DD}= 125V, I_D = 35A
Q_{gd}	Gate-to-Drain ("Miller") Charge	——	35	——		V_{GS} = 10V ③
t_{st}	Shoot Through Blocking Time	100	——	——	ns	V_{DD}= 200V, V_{GS} = 15V, R_G = 4.7Ω
E_{PULSE}	Energy per Pulse	——	520	——	μJ	L = 220nH,C = 0.3μF, V_{GS} = 15V V_{DD}= 200V, R_G = 5.1Ω , T_J = 25°C
		——	920	——		L = 220nH,C = 0.3μF, V_{GS} = 15V V_{DD}= 200V, R_G = 5.1Ω , T_J = 100°C
C_{iss}	Input Capacitance	——	5860	——	pF	V_{GS} = 0V
C_{oss}	Output Capacitance	——	530	——		V_{DS} = 25V
C_{rss}	Reverse Transfer Capacitance	——	130	——		f = 1.0 MHz
C_{oss} eff.	Effective Output Capacitance	——	360	——		V_{GS} = 0V, V_{DS} = 0V to 200 V
L_D	Internal Drain Inductance	——	5.0	——	nH	Between lead, 
L_S	Internal Source Inductance	——	13	——		from package

Avalanche Characteristics

	Parameter	Typ.	Max.	Units
E_{AS}	Single Pulse Avalanche Energy ②	——	210	mJ
E_{AR}	Repetitive Avalanche Energy ①	——	36	
$V_{DS(Avalanche)}$	Repetitive Avalanche Voltage ①	300	——	V
I_{AS}	Avalanche Current ②	——	35	A

Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	——	——	57	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode) ①	——	——	230	A	
V_{SD}	Diode Forward Voltage	——	——	1.3	V	T_J = 25°C, I_S = 35A, V_{GS} = 0V ③
t_{rr}	Reverse Recovery Time	——	190	290	ns	T_J = 25°C,I_F = 35A,V_{DD} = 50V
Q_{rr}	Reverse Recovery Charge	——	820	1230	nC	di/dt = 100A/μs ③

Notes:

① Repetitive rating; pulse width limited by max. Junction temperature.
② Starting T_J = 25°C, L = 0.35mH, R_G = 25Ω, I_{AS} = 35A.
③ Pulse width ≤ 400μs; duty cycle ≤ 2%.
④ R_θ is measured at T_J approximately 90°C.
⑤ Half sine wave with duty cycle = 0.25, ton=1μsec.
⑥ Applicable to Sustain and Energy Recovery applications.

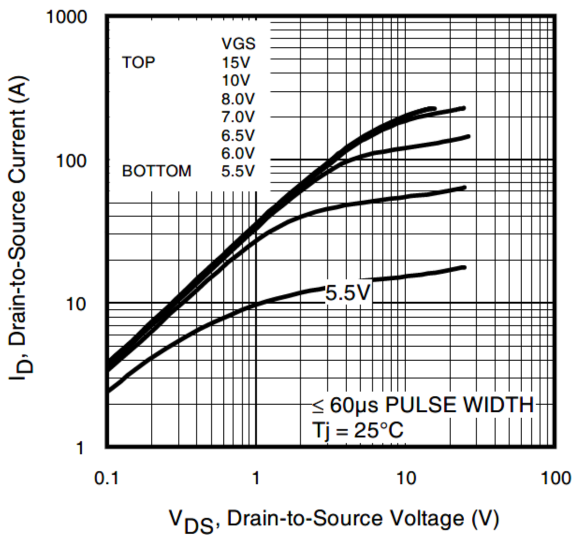


Fig 1. Typical Output Characteristics

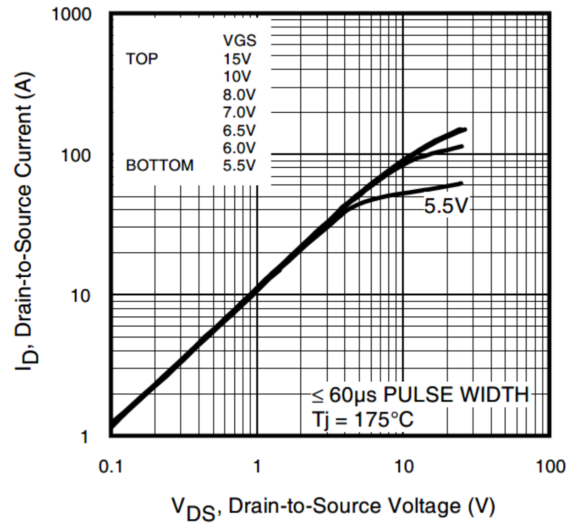


Fig 2. Typical Output Characteristics

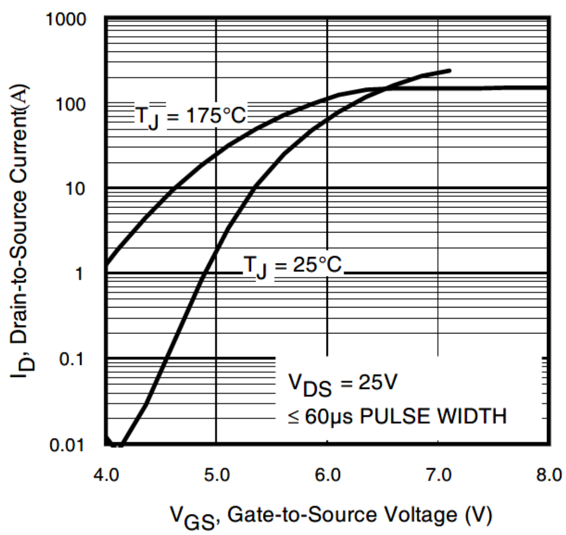


Fig 3. Typical Transfer Characteristics

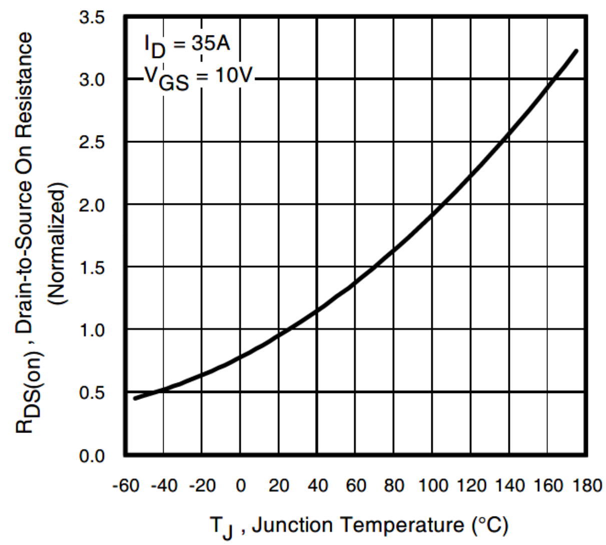


Fig 4. Normalized On-Resistance vs. Temperature

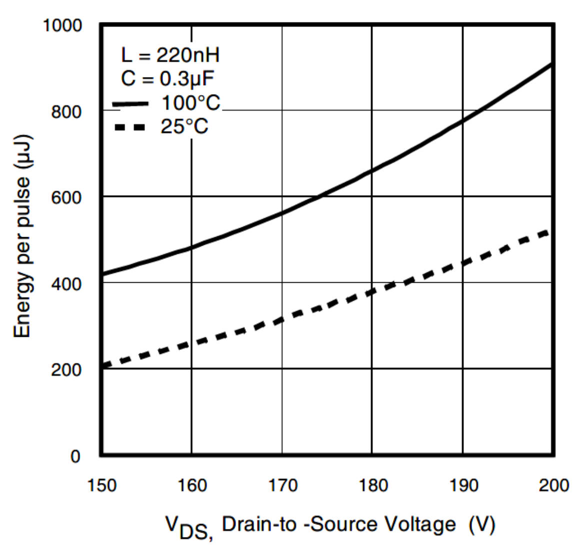


Fig 5. Typical E_{PULSE} vs. Drain-to-Source Voltage

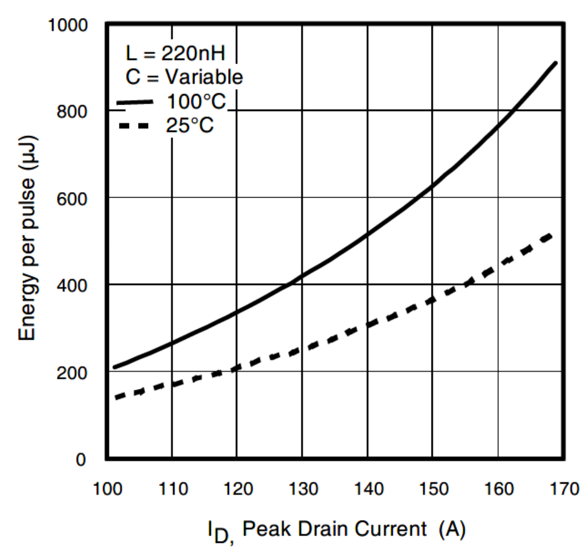


Fig 6. Typical E_{PULSE} vs. Drain Current

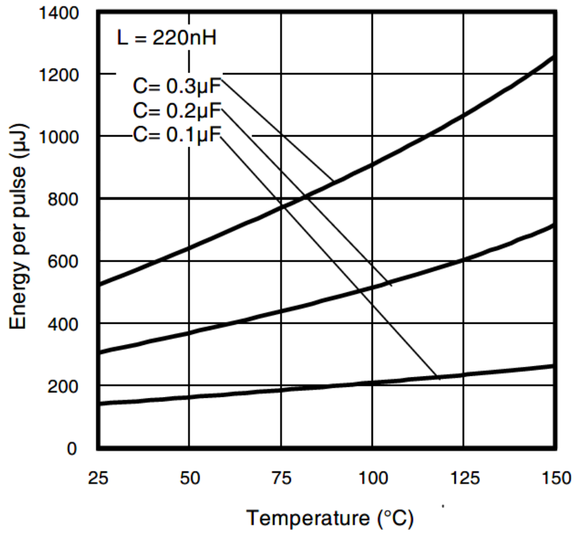


Fig 7. Typical E_{PULSE} vs. Temperature

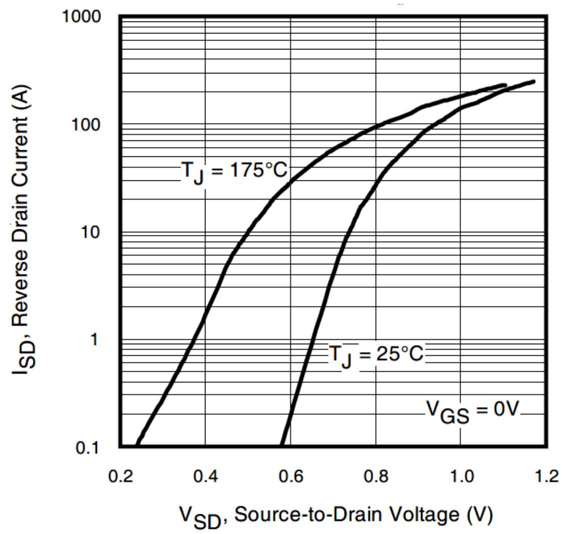


Fig 8. Typical Source-Drain Diode Forward Voltage

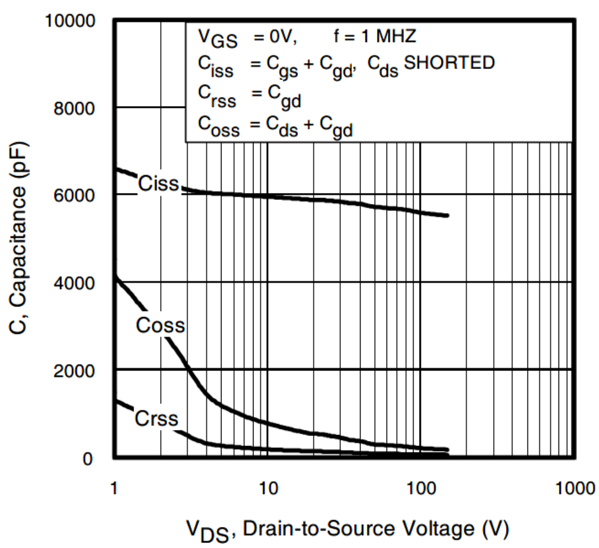


Fig 9. Typical Capacitance vs. Drain-to-Source Voltage

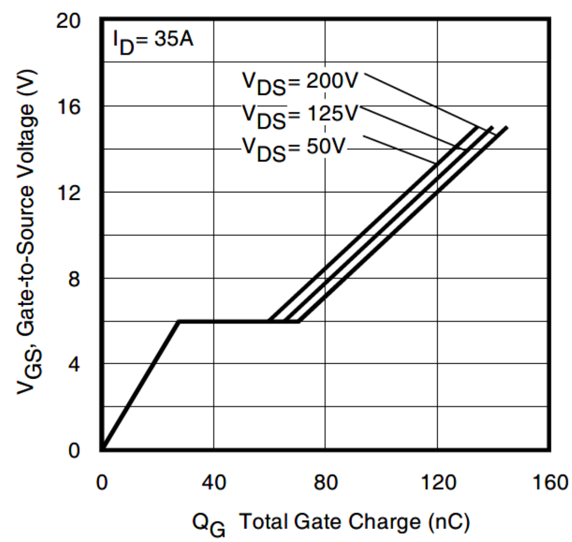


Fig 10. Typical Gate Charge vs. Gate-to-Source Voltage

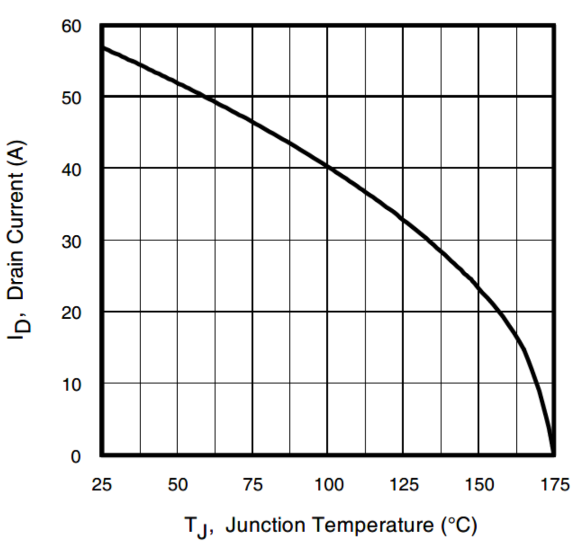


Fig 11. Maximum Drain Current vs. Case Temperature

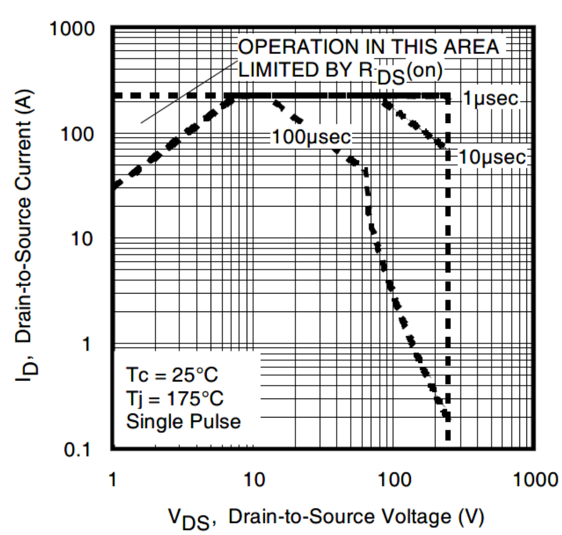


Fig 12. Maximum Safe Operating Area

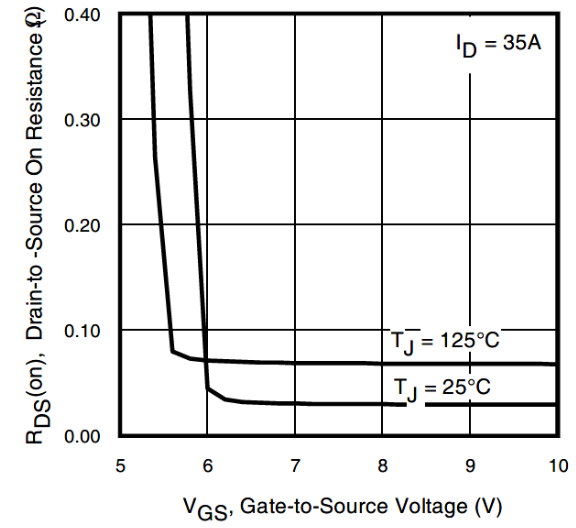


Fig 13. On-Resistance Vs. Gate Voltage

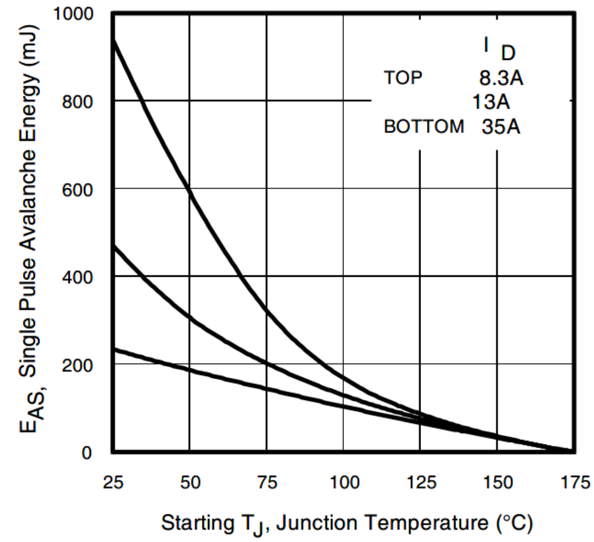


Fig 14. Maximum Avalanche Energy Vs. Temperature

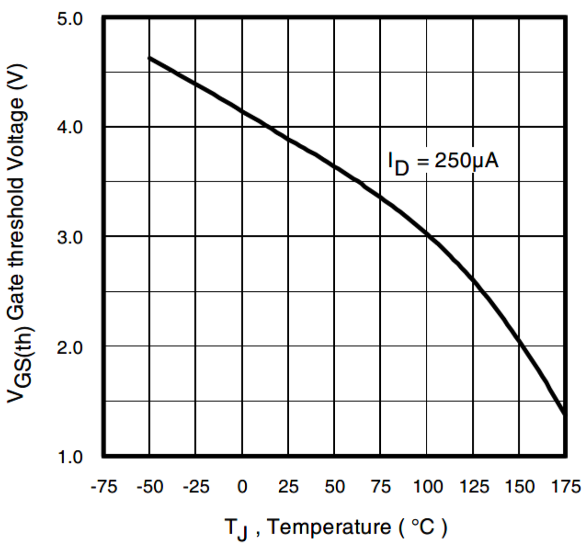


Fig 15. Threshold Voltage vs. Temperature

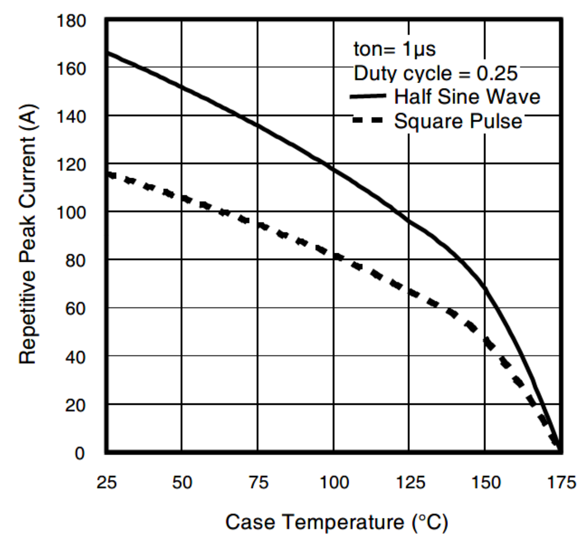


Fig 16. Typical Repetitive peak Current vs. Case temperature

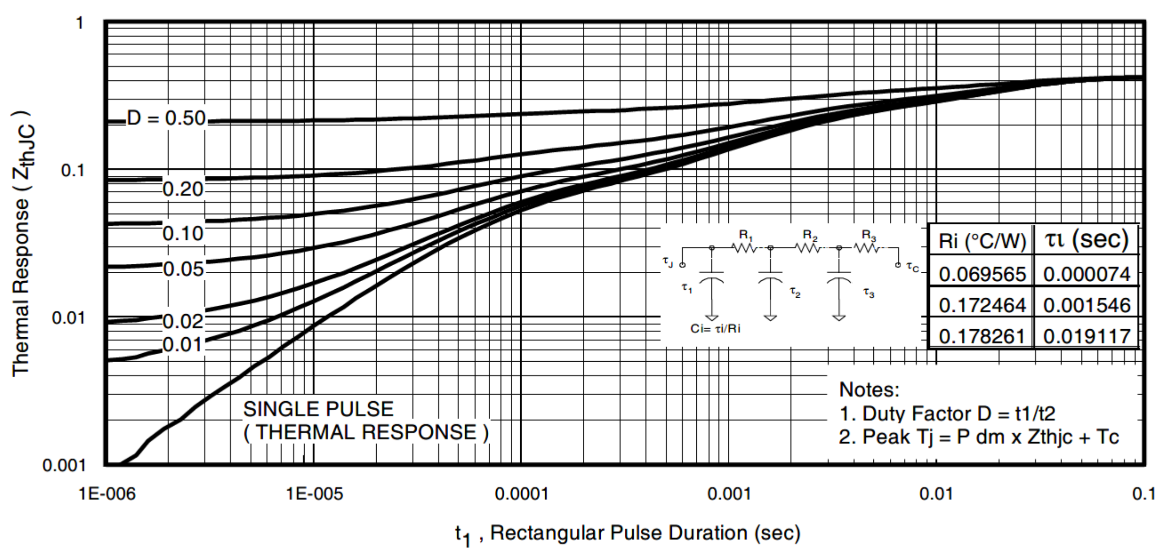
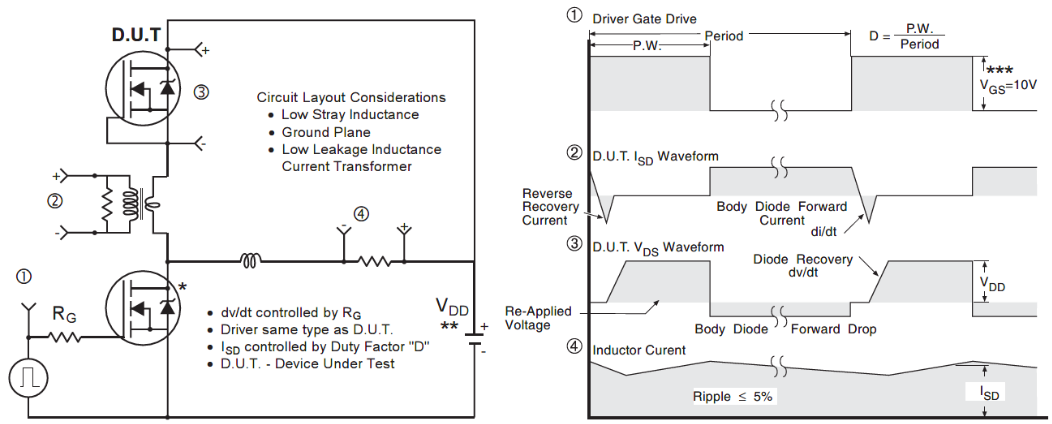


Fig 17. Maximum Effective Transient Thermal Impedance, Junction-to-Case



* Use P-Channel Driver for P-Channel Measurements
** Reverse Polarity for P-Channel

*** V_{GS} = 5V for Logic Level Devices

Fig 18. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

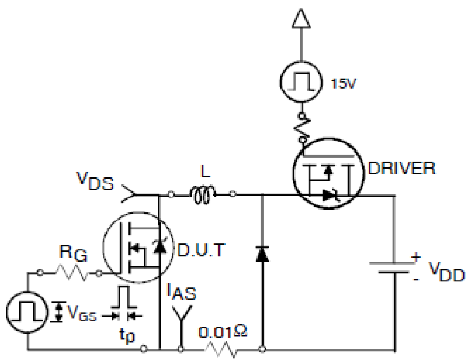


Fig 19a. Unclamped Inductive Test Circuit

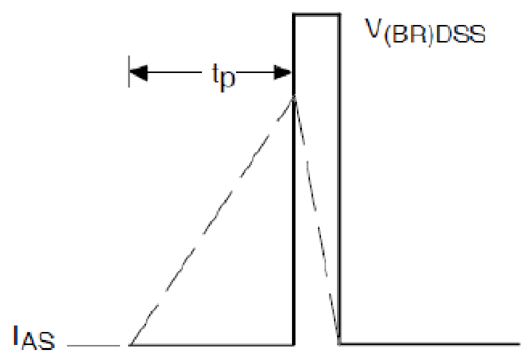


Fig 19b. Unclamped Inductive Waveforms

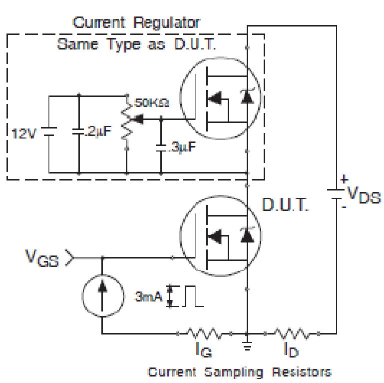


Fig 20a. Gate Charge Test Circuit

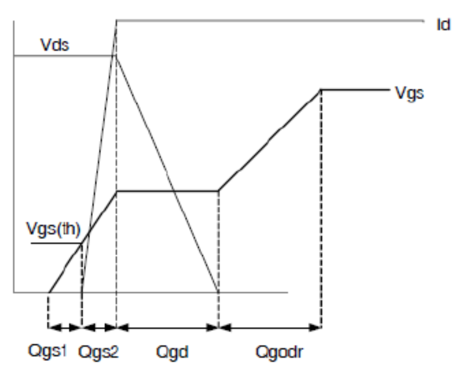


Fig 20b. Gate Charge Waveform

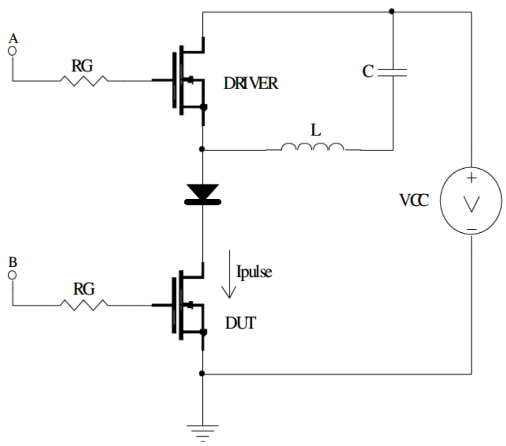


Fig 21a. t_{st} and E_{PULSE} Test Circuit

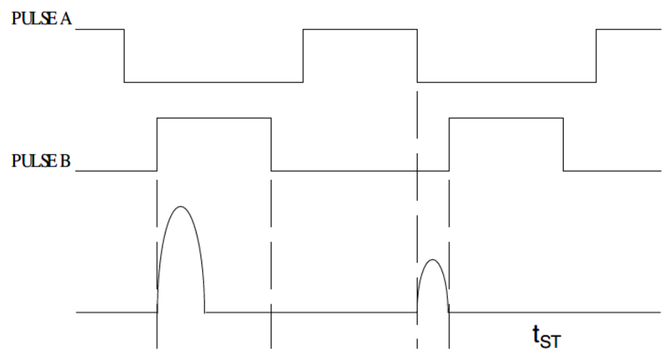


Fig 21b. t_{st} Test Waveforms

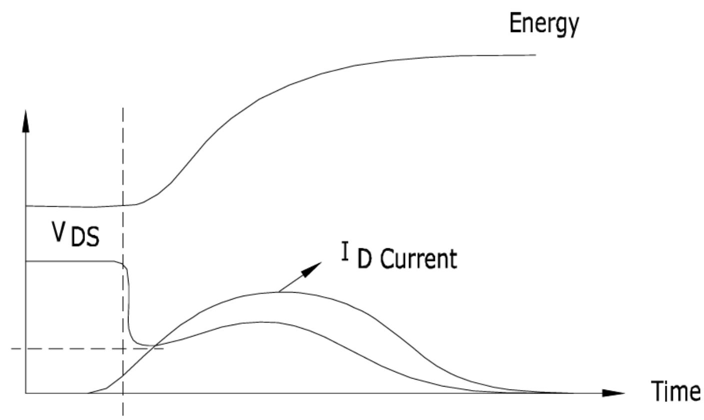
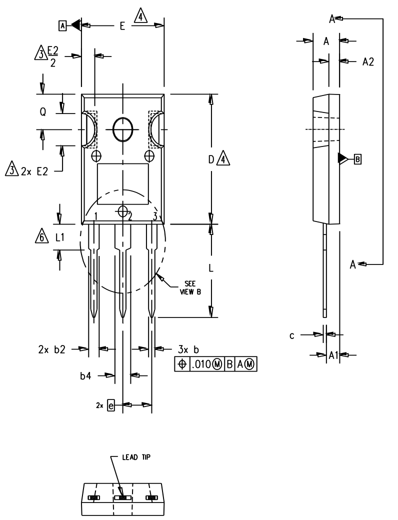
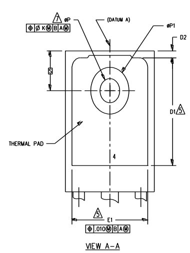
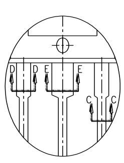


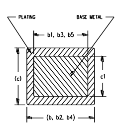
Fig 21c. E_{PULSE} Test Waveforms

TO-247AC Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.
2. DIMENSIONS ARE SHOWN IN INCHES.
3. CONTOUR OF SLOT OPTIONAL.
4. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
5. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.
6. LEAD FINISH UNCONTROLLED IN L1.
7. øP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 ° TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.
8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC .

SYMBOL	DIMENSIONS				NOTES
	INCHES		MILLIMETERS		
	MIN.	MAX.	MIN.	MAX.	
A	.183	.209	4.65	5.31	
A1	.087	.102	2.21	2.59	
A2	.059	.098	1.50	2.49	
b	.039	.055	0.99	1.40	
b1	.039	.053	0.99	1.35	
b2	.065	.094	1.65	2.39	
b3	.065	.092	1.65	2.34	
b4	.102	.135	2.59	3.43	
b5	.102	.133	2.59	3.38	
c	.015	.035	0.38	0.89	
c1	.015	.033	0.38	0.84	
D	.776	.815	19.71	20.70	4
D1	.515	–	13.08	–	5
D2	.020	.053	0.51	1.35	
E	.602	.625	15.29	15.87	4
E1	.530	–	13.46	–	
E2	.178	.216	4.52	5.49	
e	.215 BSC		5.46 BSC		
øk	.010		0.25		
L	.559	.634	14.20	16.10	
L1	.146	.169	3.71	4.29	
øP	.140	.144	3.56	3.66	
øP1	–	.291	–	7.39	
Q	.209	.224	5.31	5.69	
S	.217 BSC		5.51 BSC		

LEAD ASSIGNMENTS

HEXFET

1.- GATE
2.- DRAIN
3.- SOURCE
4.- DRAIN

IGBTs, CoPACK

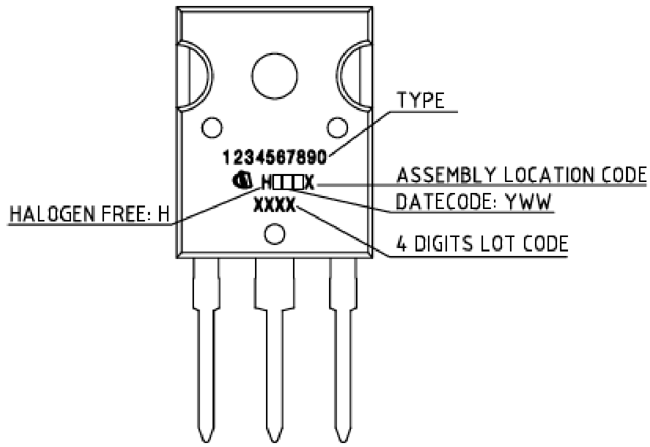
1.- GATE
2.- COLLECTOR
3.- EMITTER
4.- COLLECTOR

DIODES

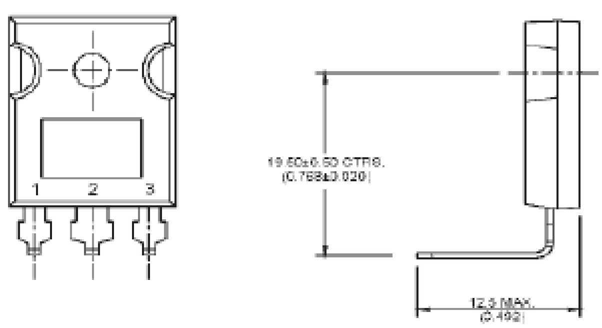
1.- ANODE/OPEN
2.- CATHODE
3.- ANODE

TO-247AC package is not recommended for Surface Mount Application.

TO-247AC Part Marking Information



TO-247AC Lead Option- 203 (Dimensions are shown in millimeters (inches))



Lead Assignments
1- Gate
2- Drain
3- Source

TO-247AC package is not recommended for Surface Mount Application.

Revision History

Date	Rev.	Comments
09/08/2008	2.1	• Added—IRP spec "IRP max @Tc=100degC –page1
12/15/2009	2.2	• Added Part Marking drawing for Leadform -203 –pg9
11/25/2024	2.3	• Update datasheet to Infineon format • Updated Part marking –page 9 • Added disclaimer on last page.

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The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

Information

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

Warnings

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

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